

承 認 書 SPECIFICATION FOR APPROVAL

客戶名稱 CUSTOMER	:	
客户料號 CUSTOMER'S P/N	:	
料號 PART NUMBER	:	WAN3216F245H08
規格 DESCRIPTION	:	Chip Antenna 3216 L Ant 2.45G Type H08
版本 VERSION	:	V1.5
日期 ISSUF DATE	:	2021/03/03

客戶承認 CUSTOMER APPROVED

	工 程 部 R&D CENTER	
承 認 APPROVAL	確 認 CHECKED	製 作 DRAWN
Ray	Tennyson	Snow





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OneWave Electronic Co., Ltd.

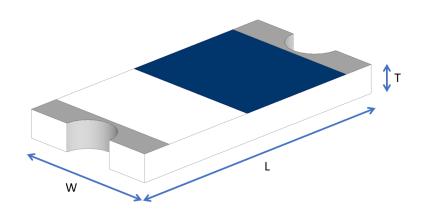
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3216 Chip antenna

For Bluetooth / WLAN Applications



P/N: WAN3216F245H08

	Dimension (mm)
L	3.23 ± 0.20
W	1.66 ± 0.20
Т	0.45 ± 0.20



External Dimensions

Outline	Size Inch (mm)	L (mm)	W (mm)	T (mm)	A (mm)	B (mm)	C (mm)
D C C ↑ ↑ T	1206 (3216)	3.23 ± 0.20	1.66 ± 0.20	0.45 ± 0.20	0.35 ± 0.075	1.10 ± 0.075	1.40 ± 0.075



Part Number Information

WAN 3216 F 245 H 08
A B C D E F

Α	Product Series	Antenna
В	Dimension L x W	3.2 x 1.6mm (±0.2mm)
C	Material	High K material
D	Working Frequency	2.4 ~ 2.5GHz
E	Feeding mode	PIFA & Single Feeding
F	Antenna type	Type = 08

1. Electrical Specification

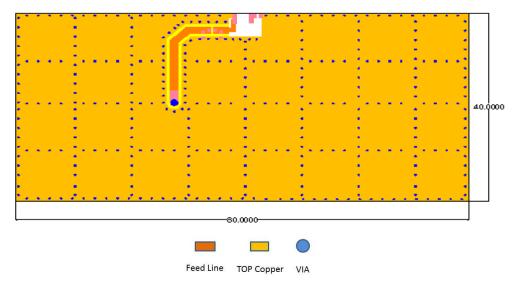
Specification					
Part Number	WAN3216F245H08				
Central Frequency	2450	MHz			
Bandwidth	120 (Min.)	MHz			
Return Loss	-6.5 (Max)	dB			
Peak Gain	1.75	dBi			
Impedance	50	Ohm			
Operating Temperature	-40~+110	°C			
Maximum Power	4	W			
Resistance to Soldering Heats	10 (@ 260°C)	sec.			
Polarization	Linear				
Azimuth Beamwidth	Omni-directional				
Termination	Ni / Au (Leadless)				

Remark: Bandwidth & Peak Gain was measured under evaluation board of next page

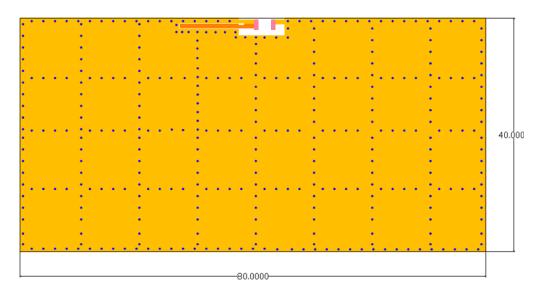


2. Recommended PCB Pattern

Recommended PCB Pattern 若未參照我司規格書上Layout建議做設計, Evaluation Board Dimension 進而造成後續生產上的天線特性與品質差異問題, 我司將不負責處理。



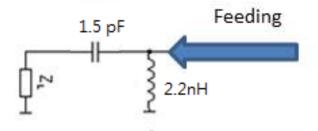
2nd Evaluation Board Dimension



Suggested Matching Circuit

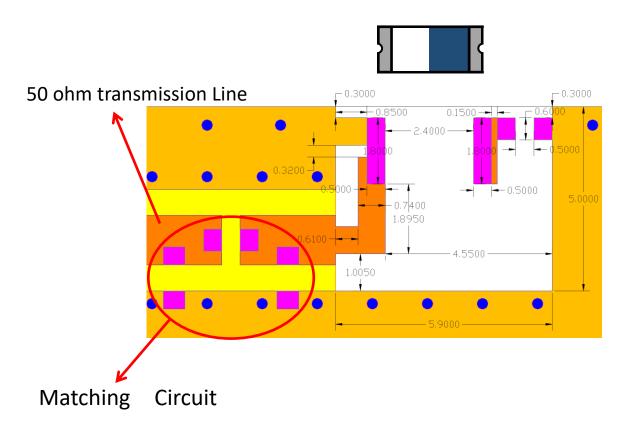
重要資訊:

匹配元件建議使用精準度高的電感±0.1~0.3nH、電容±0.1pF

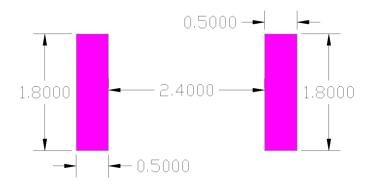




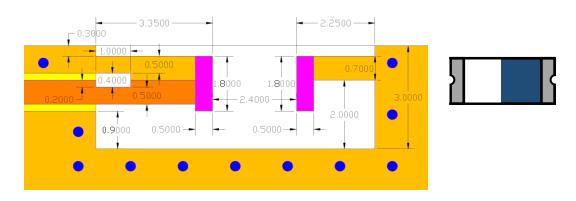
Layout Dimensions in Clearance area(Size=5.9*5.0mm)



FootPrint (Unit:mm)

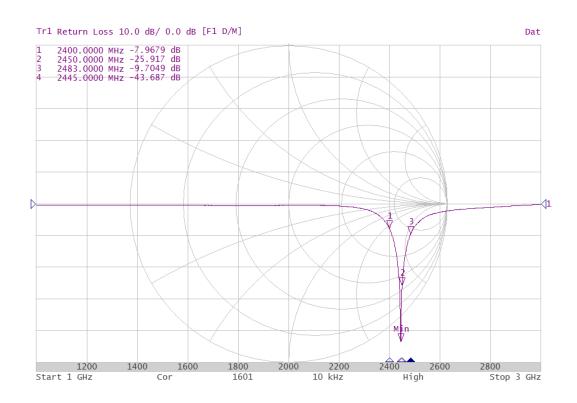


◆ 2nd Layout Dimensions in Clearance area(Size=8.0*3.0mm)



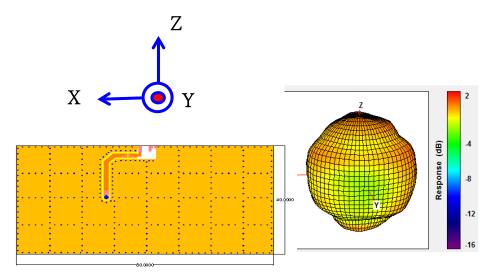


3. Measurement Results Return Loss

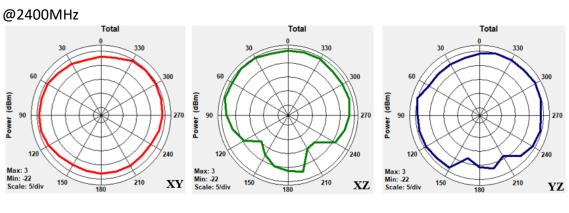


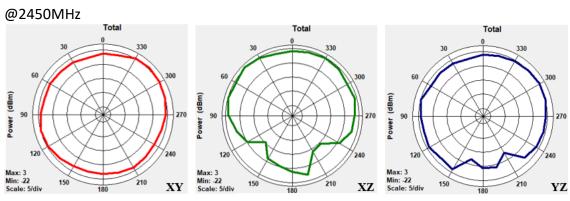


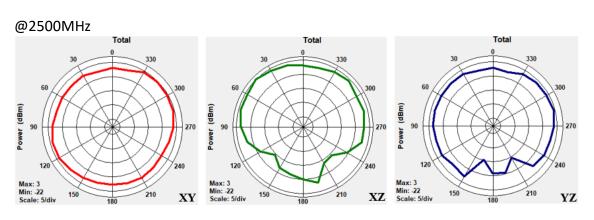
3D Radiation Pattern



2D Radiation Pattern



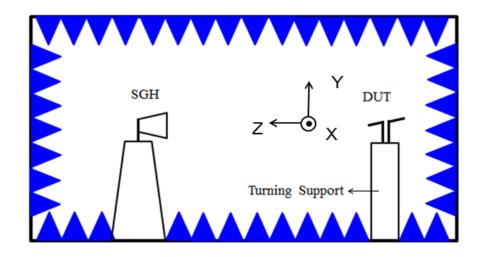






	Efficiency	Peak Gain	Directivity
2400MHz	81.46%	1.67 dBi	2.56 dBi
2450MHz	84.75%	1.75 dBi	2.46 dBi
2500MHz	82.68%	1.70 dBi	2.52 dBi

Chamber Coordinate System





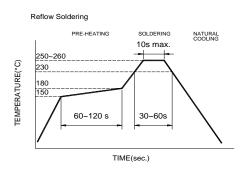
4.Reliability and Test Condictions

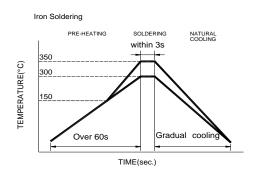
ITEM	REQUIREMENTS	TEST CONDITION		
Solderability	Wetting shall exceed 90% coverage No visible mechanical damage	Pre-heating temperature:150°C/60sec. Solder temperature:230±5°C		
	TEMP (℃)	Duration:4±1sec.		
	230°C 4±1 sec.	Solder:Sn-Ag3.0-Cu0.5 Flux for lead free: rosin		
	230 C			
	150°C			
	60sec			
Solder heat	No visible mechanical damage	Pre-heating temperature:150°C/60sec.		
Resistance	2. Central Freq. change :within ± 6%	Solder temperature:260 \pm 5 $^{\circ}$ C		
	TEMP (°C)	Duration:10±0.5sec. Solder:Sn-Ag3.0-Cu0.5		
	260°C 10±0.5 sec.	Flux for lead free: rosin		
	150°C			
	60sec			
Component	1. No visible mechanical damage	The device should be reflow		
Adhesion (Push test)		soldered(230±5°C for 10sec.) to a tinned copper substrate A dynometer force gauge should be applied the side of the component. The device must with-ST-F 0.5 Kg without failure of the termination		
		attached to component.		
Component	No visible mechanical damage	Insert 10cm wire into the remaining open		
Adhesion (Pull test)		eye bend ,the ends of even wire lengths upward and wind together.		
(i dii tost)		Terminal shall not be remarkably		
		damaged.		
Thermal shock	1. No visible mechanical damage	+110°C =>30±3min -40°C =>30±3min		
	2. Central Freq. change :within ±6%	Test cycle:10 cycles		
	Phase Temperature(°C) Time(min) 1 +110±5°C 30+3	The chip shall be stabilized at normal		
	1 +110±5°C 30±3 2 Room Within	condition for 2~3 hours before measuring.		
	Temperature 3sec	measuring.		
	3 -40±2°C 30±3			
	4 Room Within Temperature 3sec			
Resistance to		Temperature: +110±5°C		
High	 No visible mechanical damage Central Freq. change :within ±6% 	Duration: 1000±12hrs		
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal		
		condition for 2~3 hours before		
Resistance to	No visible mechanical damage	measuring. Temperature:-40±5°C		
Low	2. Central Freq. change :within ±6%	Duration: 1000±12hrs		
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal		
		condition for 2~3 hours before measuring.		
Humidity	No visible mechanical damage	Temperature: 40±2°C		
•	2. Central Freq. change :within ±6%	Humidity: 90% to 95% RH		
	3. No disconnection or short circuit.	Duration: 1000±12hrs The chin shall be stabilized at normal		
		The chip shall be stabilized at normal condition for 2~3 hours before		
		measuring.		



5. Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.





Recommended temperature profiles for re-flow soldering in Figure 1.

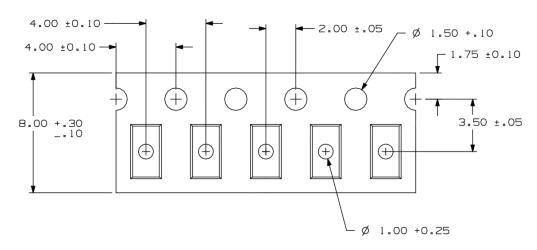
Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

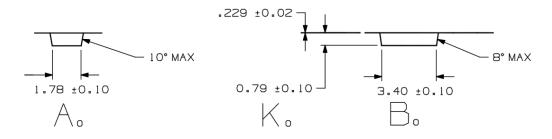
- Preheat circuit and products to 150°C
- Never contact the ceramic with the iron tip
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- 280°C tip temperature (max)
- 1.0mm tip diameter (max)
- · Limit soldering time to 3 sec.



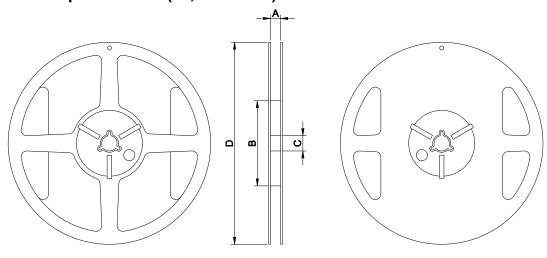
6.Packaging Information

Tape Specification:





Reel Specification: (7", Ф180 mm)



7" x 8 mm

Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
8	9.0±0.5	60±2	13.5±0.5	178±2	3000



7. Storage and Transportation Information

Storage Conditions

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40°C and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

Transportation Conditions

- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.